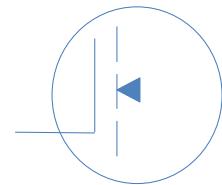


30V N-Ch Power MOSFET

V_{DS}	30	V
$R_{DS(on),typ}$	$V_{GS}=10V$	4.3 mΩ
$R_{DS(on),typ}$	$V_{GS}=4.5V$	6.4 mΩ
I_D	18	A



Part Number	Package	Marking
HTS060N03	SOIC-8	TS060N03

Absolute Maximum Ratings at $T_J=25^\circ C$ (unless otherwise specified)

Parameter	Symbol	Conditions	Value	Unit
Continuous Drain Current (Silicon Limited)	I_D	$T_A=25^\circ C$	18	A
		$T_A=100^\circ C$	12	
Drain to Source Voltage	V_{DS}	-	30	V
Gate to Source Voltage	V_{GS}	-	± 20	V
Pulsed Drain Current	I_{DM}	-	72	A
Avalanche Energy, Single Pulse	E_{AS}	$L=0.1mH, T_C=25^\circ C$	20	mJ
Power Dissipation	P_D	$T_A=25^\circ C$	3	W
Operating and Storage Temperature	T_J, T_{stg}	-	-55 to 150	

Absolute Maximum Ratings

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-Case	$R_{\theta JC}$	25	°C/W
Thermal Resistance Junction-Ambient	$R_{\theta JA}$	50	°C/W

Electrical Characteristics at $T_j=25^\circ\text{C}$ (unless otherwise specified)

Static Characteristics

Parameter	Symbol	Conditions	Value			Unit
			min	typ	max	
Drain to Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS}=0V, I_D=250\mu\text{A}$	30	-	-	V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{GS}=V_{DS}, I_D=250\mu\text{A}$	1	1.5	3	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS}=0V, V_{DS}=24V, T_j=25^\circ\text{C}$	-	-	1	μA
		$V_{GS}=0V, V_{DS}=20V, T_j=125^\circ\text{C}$	-	-	25	
Gate to Source Leakage Current	I_{GSS}	$V_{GS}=\pm20V, V_{DS}=0V$	-	-	±100	nA
Drain to Source on Resistance	$R_{DS(\text{on})}$	$V_{GS}=10V, I_D=18A$	-	4.3	6	$\text{m}\Omega$
		$V_{GS}=4.5V, I_D=12A$	-	6.4	9.5	
Transconductance	g_{fs}	$V_{DS}=5V, I_D=18A$	-	25	-	S
Gate Resistance	R_G	$V_{GS}=0V, V_{DS} \text{ Open}, f=1\text{MHz}$	-	1.2	-	Ω

Dynamic Characteristics

Input Capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=15V, f=1\text{MHz}$	-	1983	-	pF
Output Capacitance	C_{oss}		-	328	-	
Reverse Transfer Capacitance	C_{rss}		-	287	-	
Total Gate Charge (10V)	$Q_g(10V)$	$V_{DD}=15V, I_D=18A, V_{GS}=10V$	-	41	-	nC
Total Gate Charge (4.5V)	$Q_g(4.5V)$		-	23	-	
Gate to Source Charge	Q_{gs}		-	6	-	
Gate to Drain (Miller) Charge	Q_{gd}		-	13	-	
Turn on Delay Time	$t_{d(on)}$	$V_{DD}=15V, I_D=1A, V_{GS}=10V, R_G=2.7\Omega$	-	9	-	ns
Rise time	t_r		-	20	-	
Turn off Delay Time	$t_{d(off)}$		-	25	-	
Fall Time	t_f		-	3	-	

Reverse Diode Characteristics

Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_F=4A$	-		1.2	V
Reverse Recovery Time	t_{rr}	$I_F=4A, dI_F/dt=100A/\mu\text{s}$	-	32	-	ns
Reverse Recovery Charge	Q_{rr}		-	12	-	nC

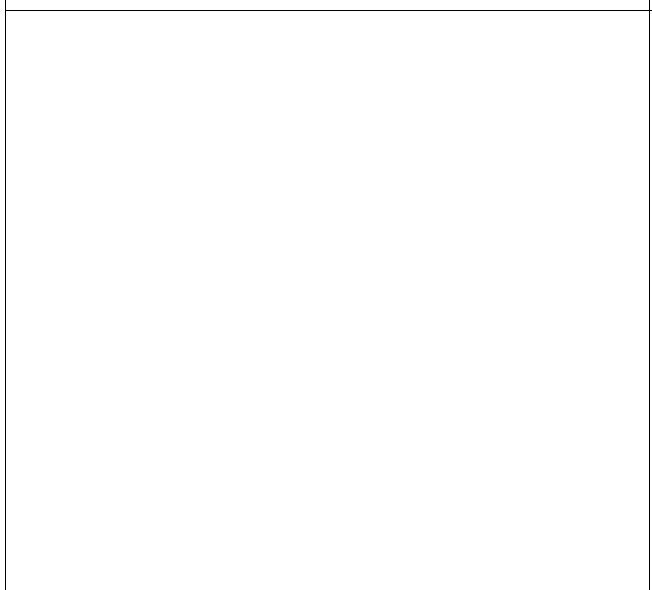
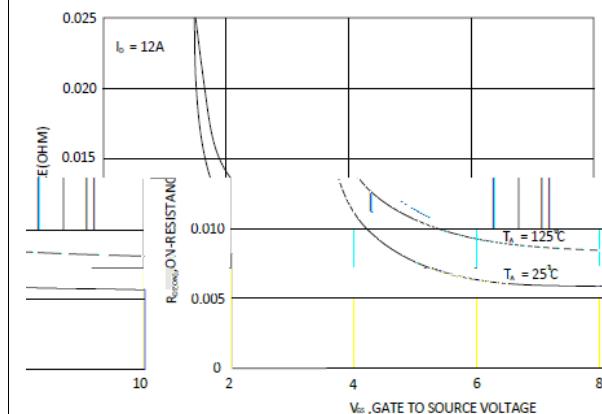
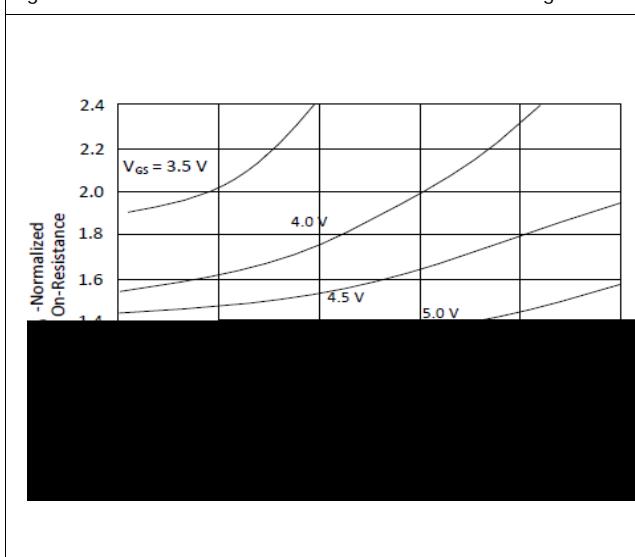
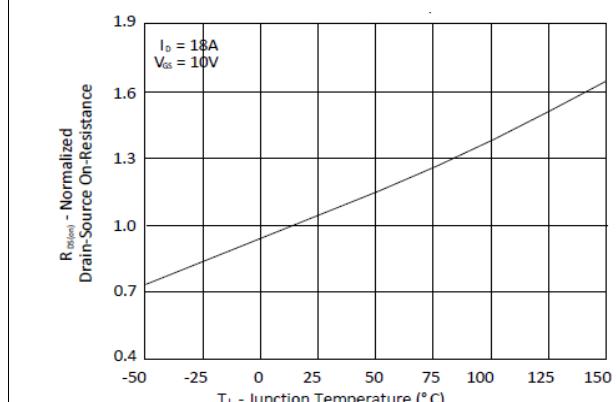
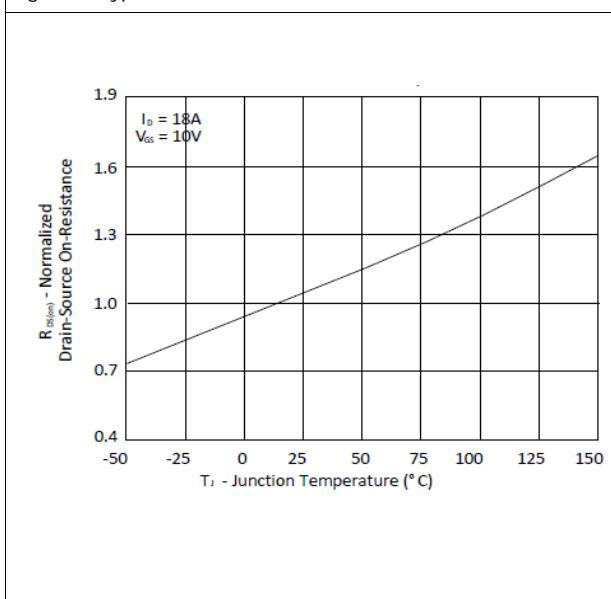
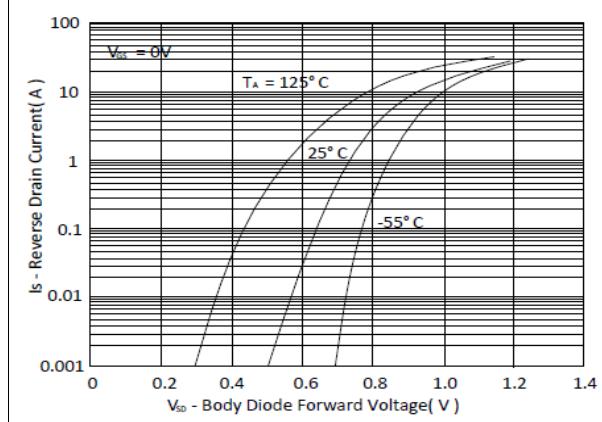
Fig 1. Typical Output Characteristics

Figure 2. On-Resistance vs. Gate-Source Voltage

Figure 3. On-Resistance vs. Drain Current and Gate Voltage

Figure 4. Normalized On-Resistance vs. Junction Temperature

Figure 5. Typical Transfer Characteristics

Figure 6. Typical Source-Drain Diode Forward Voltage


Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

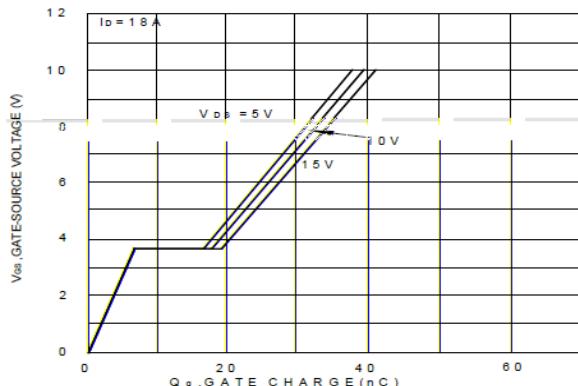


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage

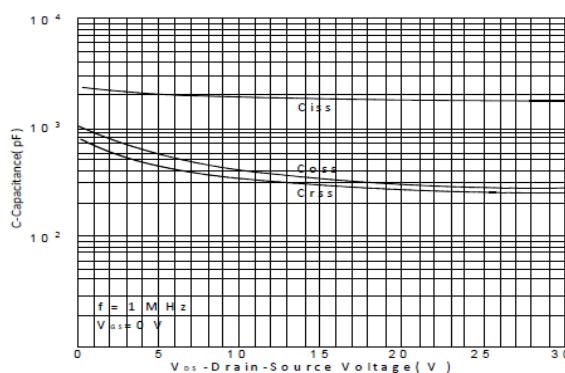


Figure 9. Maximum Safe Operating Area

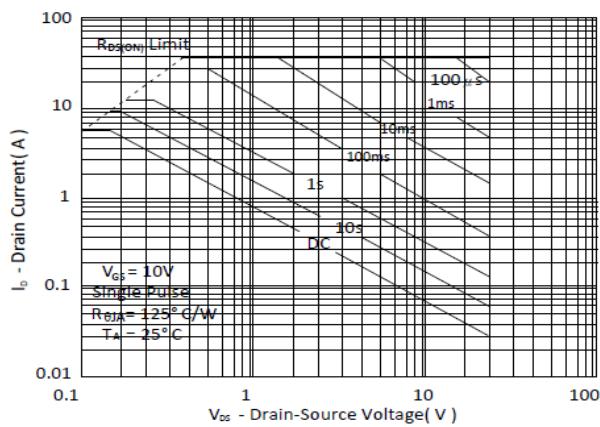


Figure 10. Single Pulse Maximum Power Dissipation

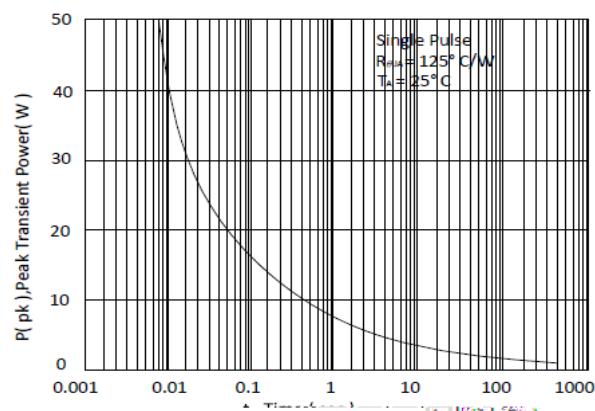
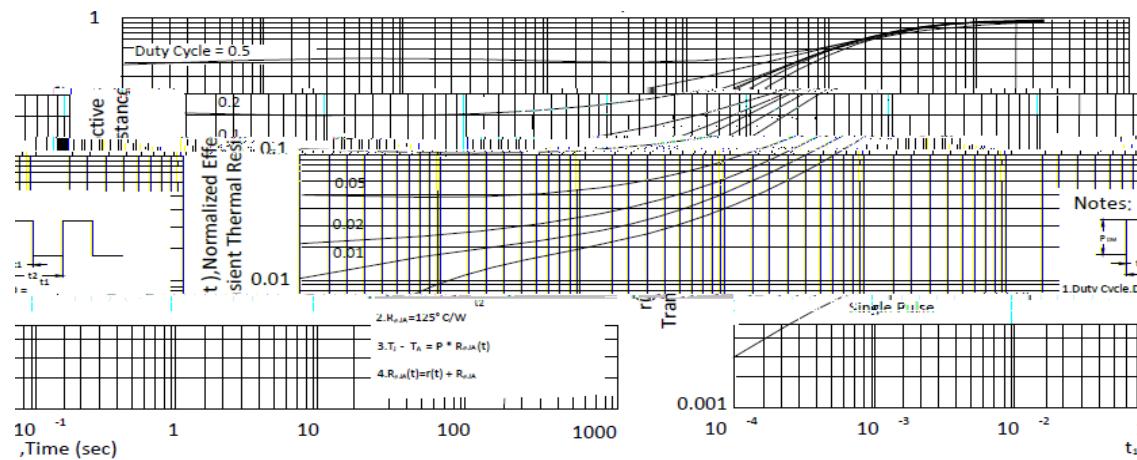
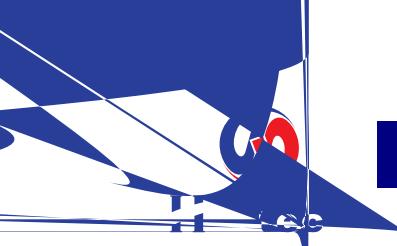


Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Case







HTS060N03

P-6

SOIC-8, 8 leads